



## 12419 - COS NUV MAMA Fold Distribution

Cycle: 18, Proposal Category: CAL/COS

(Availability Mode: RESTRICTED)

### INVESTIGATORS

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### VISITS

<i>Visit</i>	<i>Targets used in Visit</i>	<i>Configurations used in Visit</i>	<i>Orbits Used</i>	<i>Last Orbit Planner Run</i>	<i>OP Current with Visit?</i>
01	DARK DEUTERIUM	COS/NUV S/C	1	30-Mar-2011 21:05:33.0	yes

1 Total Orbits Used

### ABSTRACT

The performance of the MAMA microchannel plate can be monitored using a MAMA fold analysis procedure. The fold analysis provides a measurement of the distribution of charge cloud sizes incident upon the anode giving some measure of changes in the pulse-height distribution of the MCP and, therefore, MCP gain. This proposal executes the same steps as the COS MAMA Fold Analysis (11891) during Cycle 17.

### OBSERVING DESCRIPTION

While globally illuminating the detector with a flat field the valid event (VE) rate counter is monitored while various combinations of row and column folds are selected. The procedure is implemented using special commanding. The procedure is described below and in COS TIR 2010-01.

The proposal nomenclature for the various anode fold configurations is: C2 = Column 2, R2 = Row 2, C3 = Column 3, R3 = Row 3, C4 = Column 4,

Proposal 12419 (STScI Edit Number: 1, Created: Wednesday, March 30, 2011 8:05:37 PM EST) - Overview

R4 = Row 4, C5 = Column 5, R5 = Row 5, C6 = Column 6, and R6 = Row 6. The fold analysis is initiated by selecting the grating/lamp combination appropriate for the test. The following steps are then executed:

Select the count rate monitor and collect 60 seconds of data;

Repeat this for each of the count rate monitors W, X, Y, Z, OR, EV, VE;

Disable all of the selectable folds (C2, C3, C4, C5, C6, R2, R3, R4, R5, R6);

Collect 60 seconds of VE with folds C2, R2 enabled, other folds disabled;

Collect 60 seconds of VE with folds C2, R3 enabled, other folds disabled;

Collect 60 seconds of VE with folds C3, R2 enabled, other folds disabled;

Collect 60 seconds of VE with folds C2, R4 enabled, other folds disabled;

Collect 60 seconds of VE with folds C3, R3 enabled, other folds disabled;

Collect 60 seconds of VE with folds C4, R2 enabled, other folds disabled;

Collect 60 seconds of VE with folds C3, R4 enabled, other folds disabled;

Collect 60 seconds of VE with folds C4, R3 enabled, other folds disabled;

Collect 60 seconds of VE with folds C3, R5 enabled, other folds disabled;

Collect 60 seconds of VE with folds C4, R4 enabled, other folds disabled;

Collect 60 seconds of VE with folds C5, R3 enabled, other folds disabled;

Collect 60 seconds of VE with folds C4, R5 enabled, other folds disabled;

Collect 60 seconds of VE with folds C5, R4 enabled, other folds disabled;

Collect 60 seconds of VE with folds C4, R6 enabled, other folds disabled;

Collect 60 seconds of VE with folds C5, R5 enabled, other folds disabled;

Collect 60 seconds of VE with folds C6, R4 enabled, other folds disabled;

Collect 60 seconds of VE with folds C5, R6 enabled, other folds disabled;

Collect 60 seconds of VE with folds C6, R5 enabled, other folds disabled;

Collect 60 seconds of VE with folds C6, R6 enabled, other folds disabled;

Enable all selectable folds (C2, C3, C4, C5, C6, R2, R3, R4, R5, R6);

Collect 60 seconds of EV and 5 samples of VE counts to measure any lamp drift;

Turn off the lamp;

Select the W count rate monitor and collect 60 seconds of data for the dark rate;

Repeat this for each of the other count rate monitors (X, Y, Z, OR, EV, and EV);

Restore the global monitor to its normal value.

Analysis of the data is performed by creating a histogram binned by the sums of the fold numbers for columns and rows:

$C2R2 = 4$  folds

$C2R3 + C3R2 = 5$  folds

$C2R4 + C3R3 + C4R2 = 6$  folds

$C3R4 + C4R3 = 7$  folds

$C3R5 + C4R4 + C5R3 = 8$  folds

$C4R5 + C5R4 = 9$  folds

$C4R6 + C5R5 + C6R4 = 10$  folds

$C5R6 + C6R5 = 11$  folds

$C6R6 = 12$  folds

The sum of the 4 to 12 folds is equal to VE. The total number of events  $\geq 4$  folds is EV. The number of events greater than 12 folds is EV-VE.

Generate a plot of 4 fold/EV, 5 fold/EV through 12 fold/EV, with  $(EV-VE)/EV$  on the abscissa and with the ordinate labeled 4 fold, 5 fold..... 12 fold.

Results are sent to the Science Team and Vic Argabright of Ball Aerospace.

### **ADDITIONAL COMMENTS**

Bright Object Protection Considerations. During the execution of the fold analysis some anode folds are disabled. Consequently, the OR counter does not provide a true representation of the OR count and so the Software Global Monitor (SGM) does not trigger until the enabled folds provide enough counts to the OR counter to trigger the SGM's threshold. To compensate, while the fold analysis is running the SGM threshold is reduced to 100,000 counts in a 1.0 second interval, from its nominal value of 20,000 counts in a 0.1 second interval.

This test should only be run with the COS external shutter closed.

Special Commanding is used in this proposal.

Proposal 12419 - Visit 01 - COS NUV MAMA Fold Distribution

Thu Mar 31 01:05:37 GMT 2011

<b>Visit</b>	<b>Proposal 12419, Visit 01, implementation</b> <b>Diagnostic Status: Warning</b> Scientific Instruments: COS/NUV, S/C Special Requirements: GYRO MODE 3GOBAD; BETWEEN 01-MAY-2011:00:00:00 AND 01-JUN-2011:00:00:00; PARALLEL <i>Comments: Schedule one NUV MAMA fold analysis visit per year</i>									
	<b>Diagnosics</b> (Visit 01) Warning (Orbit Planner): MAXIMUM DURATION EXCEEDED FOR INTERNAL OR EARTH CALIB SU									
<b>Exposures</b>	<b>#</b>	<b>Label</b>	<b>Target</b>	<b>Config,Mode,Aperture</b>	<b>Spectral Els.</b>	<b>Opt. Params.</b>	<b>Special Reqs.</b>	<b>Groups</b>	<b>Exp. Time/[Actual Dur.]</b>	<b>Orbit</b>
	1	Fold Test Setup	DARK	S/C, DATA, NONE			SAA CONTOUR 32; SPEC COM INSTR ELFOLDSET	Same Alignment in Visit 01	475.0 Secs [==>]	[1]
	<i>Comments: Special setup for NUV Fold Analysis Test. Set the Software Global Monitor to 150,000 ORCOUNTS per sec (sufficient to allow for spike at lamp turn-on).</i>									
2	Fold Test	DEUTERIUM	COS/NUV, TIME-TAG, FCA	G185M 1850 A	CURRENT=MEDIU M; BUFFER-TIME=27 00	SPEC COM INSTR ELFOLDTST; QESIPARM TARG TYPE FOLD	Same Alignment in Visit 01	2300.0 Secs [==>]	[1]	
<i>Comments: The NUV Fold Analysis Test will be conducted during a deuterium lamp time-tag exposure. The exposure specification will ensure that the FCA aperture will be used, that the OSMs will be positioned at N CM1FLAT and G185M/1850, and that the lamp current is set to MEDIUM. Qesiparm TARGTYPE must be specified as FOLD so that the instructions will command the proper lamp. Note that the commanding will turn the lamp off during the exposure, and the exposure commanding will issue a redundant lamp off command after the exposure.</i>  <i>Set Software Global monitor SGM Threshold = 100000, SGM Integration period = 1 sec. The following steps are then executed:</i> Select the W count rate monitor and collect 60 seconds of data for the dark rate; Repeat this for each of the other count rate monitors (X, Y, Z, OR, EV, and EV); Disable all of the selectable folds (C2, C3, C4, C5, C6, R2, R3, R4, R5, R6); Collect 60 seconds of VE with folds C2, R2 enabled, other folds disabled; Collect 60 seconds of VE with folds C2, R3 enabled, other folds disabled; Collect 60 seconds of VE with folds C3, R2 enabled, other folds disabled; Collect 60 seconds of VE with folds C2, R4 enabled, other folds disabled; Collect 60 seconds of VE with folds C3, R3 enabled, other folds disabled; Collect 60 seconds of VE with folds C4, R2 enabled, other folds disabled; Collect 60 seconds of VE with folds C3, R4 enabled, other folds disabled; Collect 60 seconds of VE with folds C4, R3 enabled, other folds disabled; Collect 60 seconds of VE with folds C3, R5 enabled, other folds disabled; Collect 60 seconds of VE with folds C4, R4 enabled, other folds disabled; Collect 60 seconds of VE with folds C5, R3 enabled, other folds disabled; Collect 60 seconds of VE with folds C4, R5 enabled, other folds disabled; Collect 60 seconds of VE with folds C5, R4 enabled, other folds disabled; Collect 60 seconds of VE with folds C4, R6 enabled, other folds disabled; Collect 60 seconds of VE with folds C5, R5 enabled, other folds disabled; Collect 60 seconds of VE with folds C6, R4 enabled, other folds disabled; Collect 60 seconds of VE with folds C5, R6 enabled, other folds disabled; Collect 60 seconds of VE with folds C6, R5 enabled, other folds disabled; Collect 60 seconds of VE with folds C6, R6 enabled, other folds disabled; Enable all selectable folds (C2, C3, C4, C5, C6, R2, R3, R4, R5, R6); Collect 60 seconds of EV and 5 samples of VE counts to measure any lamp drift; Turn off the lamp; Select the W count rate monitor and collect 60 seconds of data for the dark rate; Repeat this for each of the other count rate monitors (X, Y, Z, OR, EV, and EV); Restore the global monitor to its normal value.										

